Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
09/206,329	ZHANG ET AL.
Examiner	Art Unit
George R. Evanisko	3762

SEARCHED			
Class	Subclass	Date	Examiner
same		6/16/2005	<u> </u>
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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